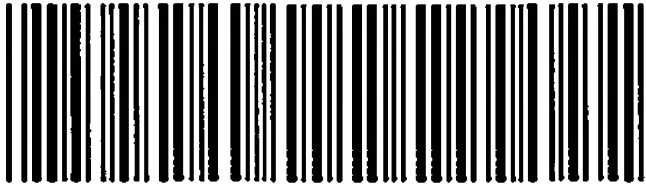


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/640,082	LEE, CHANG-HYUN	
	Examiner	Art Unit	
	Tan T. Nguyen	2827	

SEARCHED			
Class	Subclass	Date	Examiner
365	185.17	6/7/2005	TNT
365	185.18	6/7/2005	TNT
365	185.23	6/7/2005	TNT
365	185.28	6/7/2003	TNT

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
365	185.17	6/7/2005	TNT
365	185.18	6/7/2005	TNT
365	185.23	6/7/2005	TNT
365/185.28		6/7/2005	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST Search	6/7/2005	TNT